Application/Control No. Applicant(s)/Patent Under Reexamination 10/526,473 OYAMA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 John L. Goodrow 1756 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,667,140 12-2003 430/108.23 Tosaka et al. Α US-2004/0009294 01-2004 В Kuribayashi et al. 427/212 10-2003 С US-2003/0195274 Nakamura et al. 523/160 US-D US-Ε US-F US-G USн US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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